REMARKS

Applicant wishes to thank the Examiner for the courtesy of a telephone interview. The Lee et al. (PCT Publication No. WO 96/32520) was discussed per the comments set forth herein and it is believed that Claims 36 and 37 provided sufficient structure to distinguish over Lee et al. No agreement was reached on allowability and Examiner Kunemund reserved the right to further review the formal response.

In accordance with Rule 126, applicants have renumbered the previous added claims as Claims 36 and 37.

Claims 28 and 29 have been cancelled without prejudice to limit the issues in accordance with 37 CFR § 1.116.

Attached hereto is a Supplemental Declaration to affirm that the error was having only method claims considered in U.S. Patent No. 5,993,543, and not having claims directed to the apparatus and to the system examined, although they were disclosed in the specification and drawings. It is believed that the issue with regards to the Reissue Application Declaration has now been adequately addressed by this submission.

The Office Action contended that the outstanding Claims 36 and 37 would be obvious over the Lee et al. (PCT Publication WO 96/32520).

The Office Action contended that our arguments in the Amendment filed on October 4, 2004 were not persuasive because the arguments were directed to the *Lee et al.* (U.S. Patent No. 5,849,370) and that the teachings in the '370 patent were not the same as set forth in the *Lee et al.* PCT reference. Applicants respectfully traverse this position since it can be seen from WO 96/32520 that the priority data is based on the U.S. Serial No. 08/423,645 filed on April 14,

1995, which is the parent application from which a continuation application issued as U.S. Patent No. 5,849,370.

Additionally, the comments in the Amendment related directly to the same disclosure since the PCT/WO Publication teaches on Page 8, Lines 11-13, that a magnesium oxide layer is not disclosed, but rather only a magnesium fluoride coating. Additionally, the substrate is heated to approximately 200°C on Page 5, Lines 28-29. Accordingly, the Office Action was incorrect in stating that the *Lee et al.* teaches a magnesium oxide protective layer. It actually teaches a magnesium fluoride anti-reflection coating which will be generally one of many layers to form an approximate quarter wavelength design, as known in the optical field. This is consistent with the desires set forth in the PCT/WO Publication, Page 2, Lines 28-29, to provide a thin film formation for low scatter, low loss, dense films.

The PCT WO Publication disclosed an electron beam directed at a source material to evaporate material to be coated. The electron beam, however, was not utilized to provide momentum to the coating material as it was applied to the substrate. The purported invention disclosed in the PCT/WO reference can be found in the Description of the Summary of the Invention, on Page 4, Lines 13-19, as follows:

Coating material is evaporated with the electron beam gun and forms a coating material evaporant that is directed towards the substrate positioned on the substrate carrier. The ion gun is directed toward the substrate and produces ions that arrive substantially with the coating material evaporant at the substrate surface. The ions provide a momentum assist to the coating material. A dielectric thin film coating is then formed on the substrate.

Thus, this reference teaches an ion gun directed towards the substrate so that the ions will arrive substantially simultaneously with the coating material evaporant, and the ions will provide

1

a momentum assist to the coating material. The Office Action cited Page 5 for the premise that the electron beam gun can be used to grow magnesium oxide thin film, but Page 5 of the PCT/WO Publication does not mention magnesium oxide, and only states that the electron beam provides an evaporant flux. However, Page 5 does discuss at Lines 5-8, the following:

The ion/coating material evaporant arrival ratio at the substrate is controlled to create a desired density of coating material dielectric thin film layers. Further, the ions are utilized in order to increase the energy of the coating material deposited as layers on the substrate.

Thus, there is a desire to create as high as possible energy to the coating material by transferring the momentum of the ions to the depositing material. This is further explained on Page 6, Lines 1-6, as follows:

This energy is transferred or imparted to the coating molecules via a collisional process with energetic oxygen ions, of specified energy and flux, at the substrate level where the dielectric thin film microstructures take form. In this method, a key parameter is the ion/evaporant molecule arrival ratio which determines the density of the growing film.

[Underline added.]

Referring to Figure 7 of our present application, and Column 10, lines 42-47, an electron gun 42 is also used to develop an evaporant material. However, another electron gun 44 is directed at the substrate and is used to assist in the depositing of an improved, dense alkaline earth oxide with a (110)-face orientation with the electron beams impacting the surface of the dielectric layer to further evaporate the dielectric layer as it is deposited on the glass substrate, see specific examples 19, 20, 30 and 31 and Column 11, lines 1-5. Thus, the heat created through impact with the electron beam provides the desired (110)-face crystal growth with the density desired in the environment of a plasma display panel.

The present invention with a (110)-crystal face orientation created by this unique application of an electron beam to the substrate provides a very dense formation of a protective layer to improve against sputtering deterioration that can occur during the life expectancy operation of a plasma display panel. Additionally, our invention permits reducing a driving voltage of the plasma display panel and improves the panel brightness because of its large emission coefficient of secondary electrons.

The conventional (111)-face orientation further may react with water content in the air to form hydroxides and has a lower heat resistance for a resulting magnesium oxide protective layer with a (111)-face orientation.

The resulting products produced by our apparatus can have a significantly higher heat resistant and thereby can enable heat treatment to be performed in the fabrication of the plasma display panels at higher elevated temperatures of about 450°C. Thus, an aging process time to remove contaminants, which is important in extending the life of a plasma display panel, can be considerably shortened.

Applicants accordingly request reconsideration since the apparatus for applying an electron beam to the substrate surface during the coating procedure is significantly different than the ion beam procedures taught in the *Lee et al.* PCT/WO Publication. This can be appreciated when the difference in the physical property of mass between an electron and an ion is taken into consideration.

For example, the lightest element of hydrogen has a mass of 1.66 X 10⁻²⁷ (Kg). Compare this mass, however, with an electron mass of only 9.11 X 10⁻³¹ (Kg).

As can be appreciated, a hydrogen atom is not taught or suggested in the *Lee et al.* disclosure. Rather, the ion beams from the ion gun are composed of considerably heavier ions of

6

oxygen or argon, which are much larger than hydrogen in mass. Comparing, however, the hydrogen atom with the electron, the hydrogen atom is 1822 times the mass of the electron.

When ion beams are emitted onto an alkaline earth oxide, the heavier ions will collide with significantly higher mass and kinetic energy, and may have a tendency to destroy the crystal structure or to cause defects due to the energy transformed by the mass of such an accelerated ion. This can create a sputtering effect as is well-known in forming semiconductor thin films.

Our unique use of an electron beam takes advantage of a much smaller mass so that as a result, when the electrons are emitted and collide with an alkaline earth oxide, a far less impact or transfer of energy will occur and will not disrupt the growth nor destroy the crystals, thereby permitting the forming of a much more uniform and dense film with a 110-face crystal growth.

The Office Action contended that the limitations of a 110-face orientation were not given weight since it was asserted that it would be obvious to a person of ordinary skill in this field through simply routine experimentation to provide an operable crystal face orientation by using the *Lee et al.* disclosure. The *Lee et al.* disclosure, however, is deficient in teaching (1) a magnesium oxide dielectric layer, (2) the use of an electron beam for momentum transfer to the alkaline earth oxide, and (3) the creation of a 110-face crystal structure.

The Lee et al. reference is not directed to solving a problem in a plasma display panel by providing an adequate protective layer with a particular crystal orientation. It does not utilize nor teach an apparatus with an electron beam gun to be applied to the surface to assist in the formation of the particular crystal orientation. Lee et al. simply teaches a conventional electron beam for evaporation purposes only. The present invention, as set forth in the claims, does not utilize the asserted key parameter teaching of the Lee et al. reference, namely the ion/evaporant molecular arrival ratio to determine any density of a growing film.

72478.3417\PRICEJ\IRV\419242

Patent 72478-3417

It is respectfully submitted that it would not be obvious to create the apparatus of the present invention in view of the teachings of the Lee et al. reference.

It is believed that the case is now in condition for allowance, and an early notification of the same is requested.

I hereby certify that this correspondence is being transmitted via fax to 703-872-9306, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on April 26, 2005.

By: Sharon Farnus

Signature

Dated: April 26, 2005

Very truly yours,

SNELL & WILMER L.L.P.

Joseph W. Price

Registration No. 25,124

1920 Main Street, Suite 1200

Irvine, California 92614-7230

Telephone: (949) 253-4920

PTO/SB/52 (04-04)

Approved for use through 04/30/2007. OMB 0861-0033
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE
O B collection of information values if discussions.

Under the Paperwork Reduction Act of 1995, no persons are required to respond	to a collection of	information	unless it displays a valid OMB control humber.	
Under the Paparwork Reduction Nation	rue assi	GNEE	72478-3417	
reissue application declaration by t	THE MOST			
			ow.	
I hereby declare that: The residence, mailing address and citizenship of the inve	e dia aidine	Electric I	ndustrial Co., Ltd.	
The residence, mailing address and cluzership of the following assignee I am authorized to act on behalf of the following assignee and the title of my position with said assignee is:	: Managanta	Devel	opment Center	
and the title of my position with said assignee is:	101 6 14			
and the title of my position with said design. The entire title to the patent identified below is vested in a	said assigne	3e.	Lin	
Inventor	1	Citizenship Japan		
Masski Aski		- Capta-		
Residence/Mailing Address				
1606, Ozza Kadoma, Kadoma-shi, Osaka-fu, Japan		Citizen	ship	
Inventor		Japan		
Hideo Torii			1	
Residence/Mailing Address 1006, Oaza Kadomo, Kadoma-shi, Osaka-fu, Japan	· · · · · · · ·	o owach	ad hereto.	
1006, Onza Kadomo, Kadoma-shi, Osaka-fu, Japan Additional Inventors are named on separately num	berso snee			
Patent	Date of P	dreitt 1991	ned	
5,993,543	140ACHURES	BAIRT M	TH PROTECTIVE LAYER OF	
5,993,543 Title of Invention METHOD OF PRODUCING PLASMA D)IZLIWE E	WIGHT OF		
I believe said inventor(s) to be the original and first inventor and patent for which a reiss	sue patent is	sought	on the invention entitled:	
I believe said inventor(s) to be the original and first inventoring the control of producing plasma display panel. EARTH OKIDS	WITH PRE	M.ET.I.TA	E BATTELLE OF	
the specification of which				
Is attached hereto. Was filed on November 29, 2001 as reissue at Octobe	oplication ne	ımbar g	9/997,536	
1				
and was amended on (if applicable to a power in the contents of the second to above.	e) shove identii	fied spec	uffication, including the claims, as	
I have reviewed and understand the contents of the s	POAR IDONA	,,,,,,,	defined in 37 CFR 1.56.	
I have reviewed and understand to above. amended by any amendment referred to above. I acknowledge the duty to disclose information which	is material	to patent	ability as defined in 5. Co. to the com	
I hareby claim foreign priority beliefits cities.	lications			
I hereby claim foreign priority benefits tride: o PTO/SB/2B (or equivalent) listing the foreign a	ahhuranona	ve or inv	alid, for the reasons described	
I vadiv believe the original patent to be wholly or pan	nà moberan			
below. (Check all boxes that appy-/	ina.			
by reason of a defective specification of drass by reason of the patentee claiming more or is	ss than he	had the i	right to claim in the patent.	
The state of the s				
by reason of other errors.	ago 1 of 2]		to a benefit by the public which is to file (and by the L	

This collection of information is required by 37 CFR 1.175. The information is required to obtain or rotain a banefit by the public which is to file (and by the USPTO to processo) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is continued to take 30 minutes to complete, including particular confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is continued to take 30 minutes to complete another particular to the USPTO. Time will vary deponding upon the individual case. Any comments on the amount pathening, properting, and outmitting the completed application for to the USPTO. Time will vary deponding upon the individual case. Any comments and time you require to complete this form and/or suggestions for reducing this burden, chould be cent to the Chief Information Officer, U.S. Patent and Trailand Officer, U.S. Department of Commence, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEMI TO:

Commissioner for Potento, P.O. Box 1450, Alexandria, VA 32313-1450.

PTO/SB/52 (04-04)
Approved for use through 04/39/2007. OMB 0651-0033
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE to a collection of information votes at disclaims with OMB.

	U.S. Patent and Trade	Doct	ket Number (Option 72478-341	onal) 7
REISSUE APPLICATION DECLARATION	BY THE AGGIGNEE			
least one error upon which reissue is based is desc the original claims in U.S. Patent 5,993,543 are only most stem disclosed in the specification and drawings.	ribed as follows: ethod claims and failed to	provide cla	ims on the appai	ratus and
	nal sheets, if needed.]		and of the ADI	olicant.
Attach addition If errors corrected in this reissue application arose to	without any deceptive int	ention on u	9 part of the sp	
hereby appoint:	21611]	
Practitioners at Customer number:			_	
OR Practitioner(s) named below:		Dletrotic	on Number	
Name		Registrati	off Marrison	
Correspondence Address: Direct all communicati	ons about the application	n to:		
Correspondence Address. Direct Silvert				
21	611			
Customer Number: 21	611			
Customer Number: 21 OR Firm or Individual	611	-		
OR Firm or Individual Name	611			
Customer Number: 21 OR Firm or Individual	611		Zip	
Customer Number: 21 OR Firm or Individual Name Address Address	611	State	Zip	
Customer Number: 21 OR Firm or Individual Name Address	611	State	Zip	
Customer Number: 21 OR Film or Individual Name Address Address City Country Telephone	611	State State	a should state	ements mad
Customer Number: OR Firm or Individual Name Address Address City Country Telephone I hereby declare that all statements made her information and belief are believed to be true; it willful false statements and the like so made 1001, and that such willful false statements thereon, or any patent to which this declaration	ein of my own knowledgand further that these etc are punishable by fina i may jeopardize the van is directed.	State Fax ge are true interests we and imprisonalidity of the	and that all states made with transment, or both, application, a	ements made to knowledge under 18 Uny patent Is
Customer Number: 21 OR Firm or Individual Name Address Address City Country Telephone I hereby declare that all statements made her information and belief are believed to be true; willful false statements and the like so made willful false statements and the like so made	ein of my own knowledgand further that these etc are punishable by fina i may jeopardize the van is directed.	State pe are true to atements we and impriso didity of the avelopment are golden.	and that all states made with the mann, or both, application, a	ny patent is
Customer Number: OR Firm or Individual Name Address Address City Country Telephone I hereby declare that all statements made her information and belief are believed to be true; it willful false statements and the like so made 1001, and that such willful false statements thereon, or any patent to which this declaration	ein of my own knowledgand further that these state punishable by fine a may jeopardize the van is directed. Ity name) Isamu Shimu Director, IP Dire	State pe are true to atements we and impriso didity of the avelopment are golden.	and that all states made with transment, or both, application, a	ny patent is

Attorney Docket: 72478-3417 Serial No. 09/997,536

REISSUE APPLICATION DECLARATION BY THE ASSIGNEE

Additional Inventors and addresses:

Eiji Fujii

Citizenship: Japan

Address:

1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan

Mitsuhiro Ohtani

Citizenship; Japan

Address:

1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan

Takashi Inami

Citizenship: Japan

Address:

1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan

Hiroyuki Kawamura

Citizenship: Japan

Address:

1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan

Citizenship: Japan

Address:

Hiroyoshi Tanaka 1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan

Ryuichi Murai

Citizenship: Japan

Address:

1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan

Yasuhisa Ishikura

Citizenship: Japan

Address:

1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan

Yutaka Nishimura

Citizenship: Japan

Address:

1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan

Katsuyoshi Yamashita

Citizenship: Japan

Address:

1006, Oaza Kadoma, Kadoma-shi, Osaka-fu, Japan